


Metal Contacts for the Hybrid Silicon Laser

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Funding Agency : Intel Corp

Department of Electrical and Computer Engineering



Outline

- Optical communication
- Hybrid Silicon Laser
 - Need for metal-semiconductor contacts
- Measurement technique
 - Two and four point probe method
- Anatomy of a metal contact
- Measurement results

Optical Communication

Fiber optic cables

- For *long* distance communication
- Niche technology
- Expensive components

What we want

- Adapt technology to everyday use
Eg. Faster internet

Why is it important

- Replace existing copper cable
- Fast & efficient data communication

➡ **Make cheaper/better light sources**



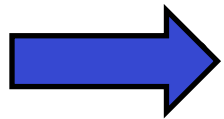
Trans-Atlantic cable



Fiber optic cable array

Outline

- Optical communication



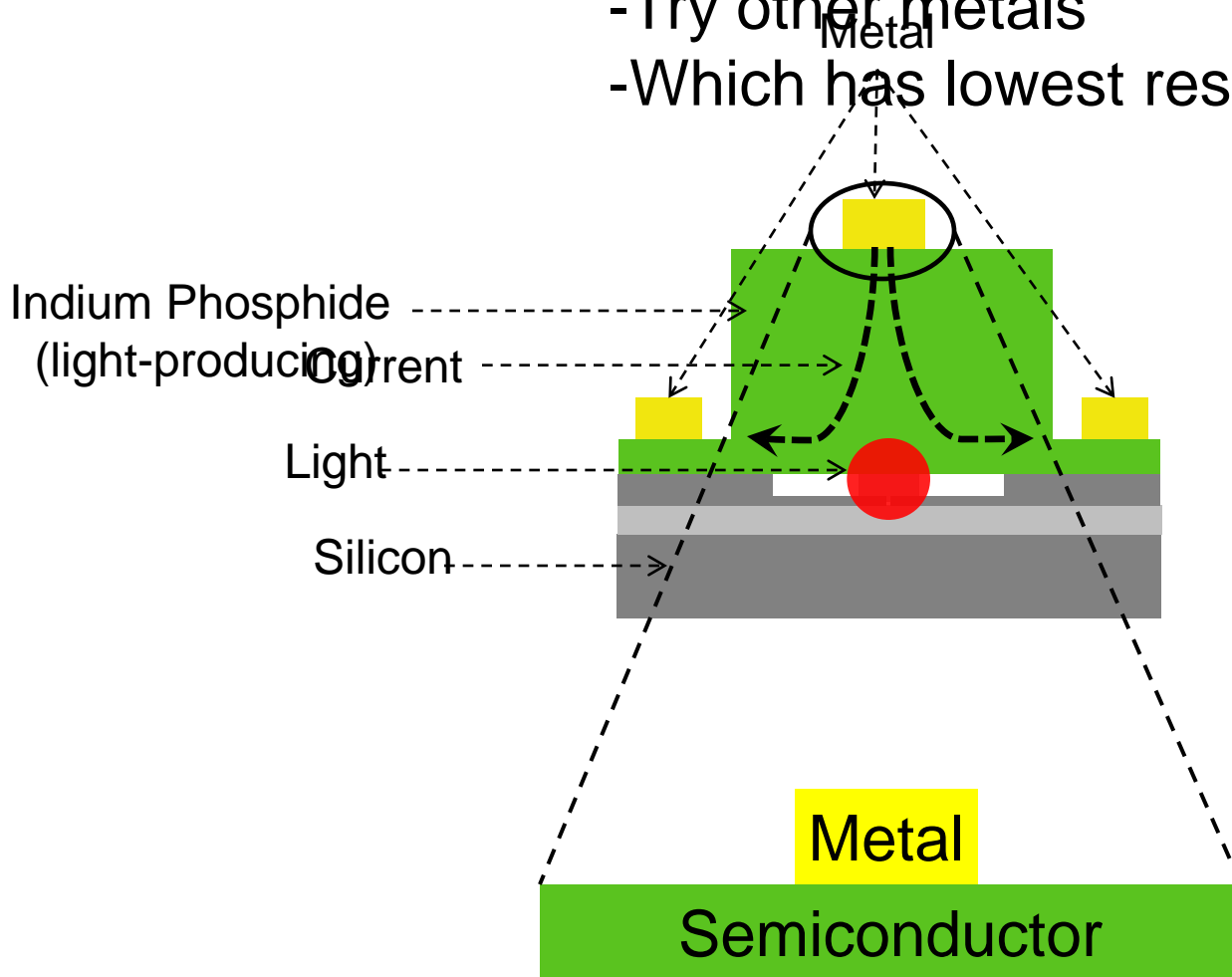
Hybrid Silicon Laser

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Hybrid Silicon Laser

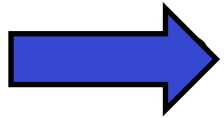
Problem: "Usual" gold contacts incompatible with Si
Aim: Convert electrical energy \rightarrow light energy
What we'll do: Study metal/semiconductor interface

- Try other metals
- Which has lowest resistance?



Outline

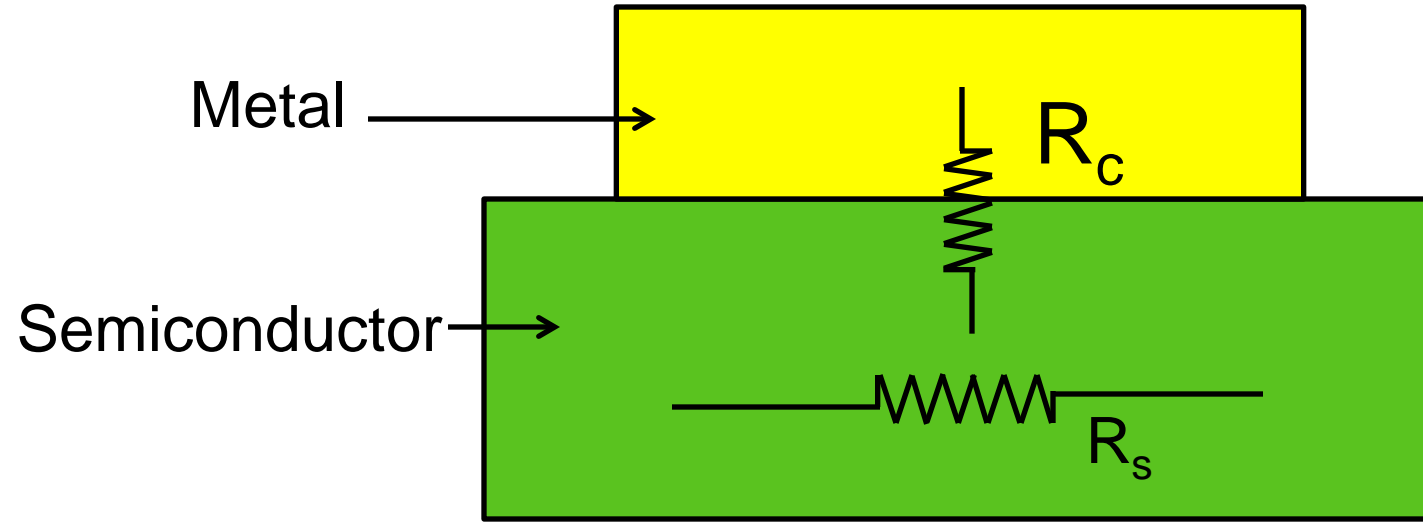
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Measurement technique

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What Do We Want to Measure?



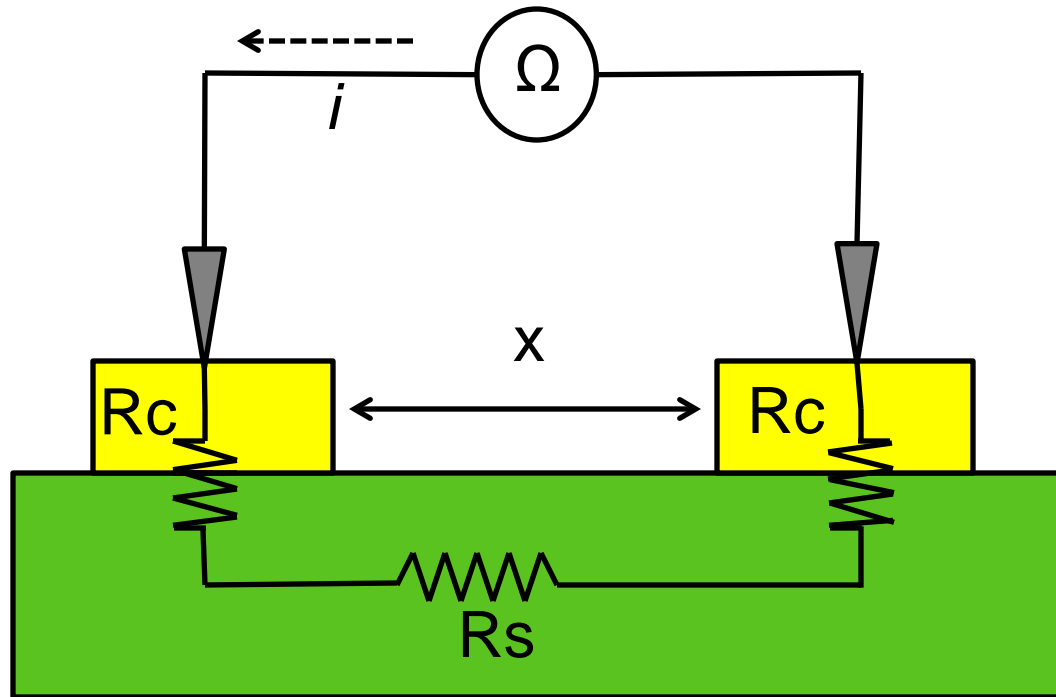
We want R_c : Contact Resistance

– R_s : Inherent resistance of semiconductor

What we actually record: *Specific* contact resistance (ρ) – takes into account area through which current flows.

Measuring Resistance

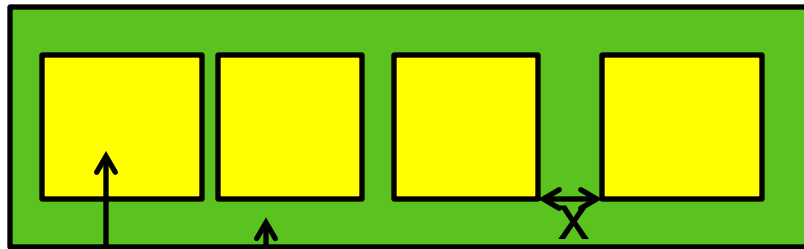
- We want to measure R_c



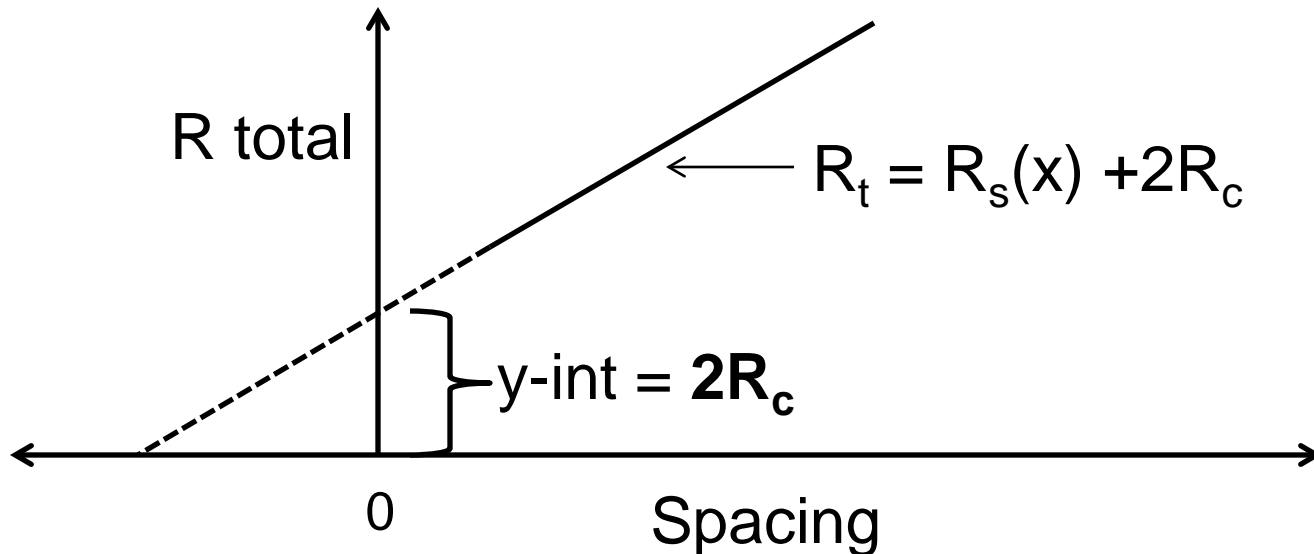
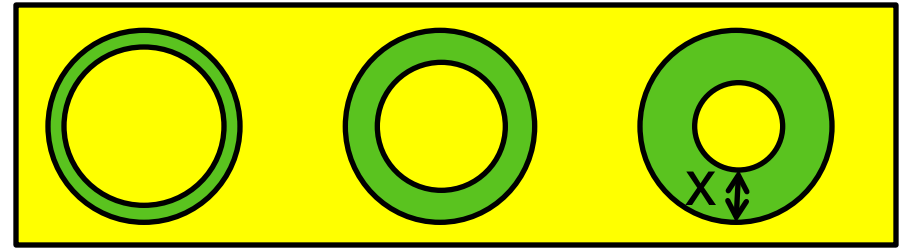
- Measured Resistance = $2R_c + R_s$

Finding Contact Resistance (R_c)

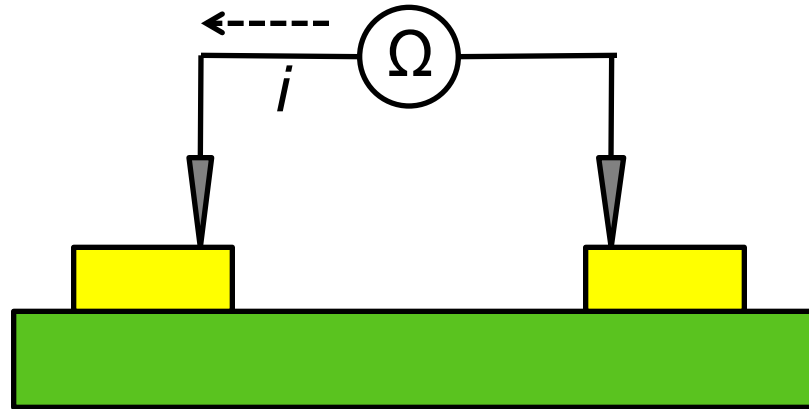
- R_s depends on spacing (x)
- Vary spacing to construct graph



metal semiconductor

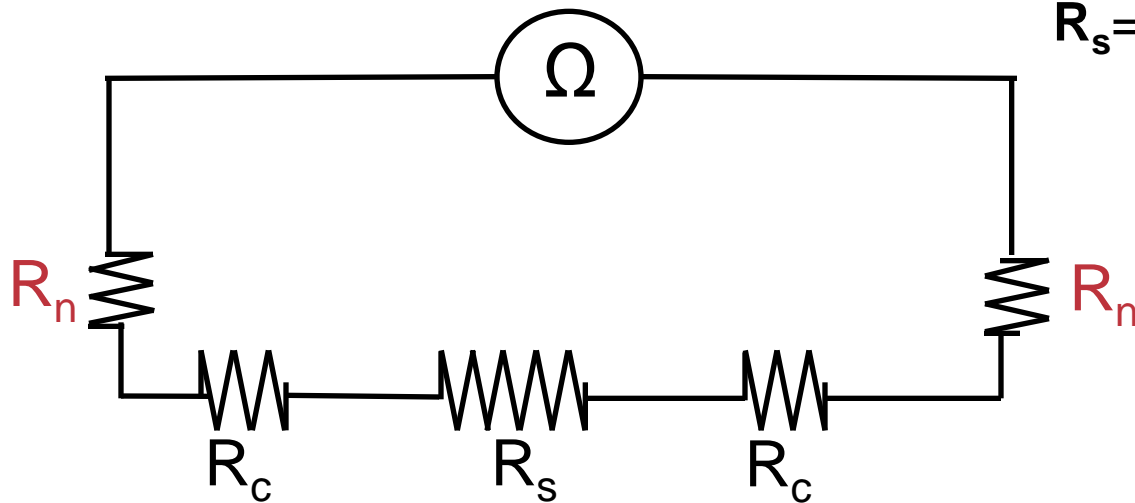


Two Point Probe Method



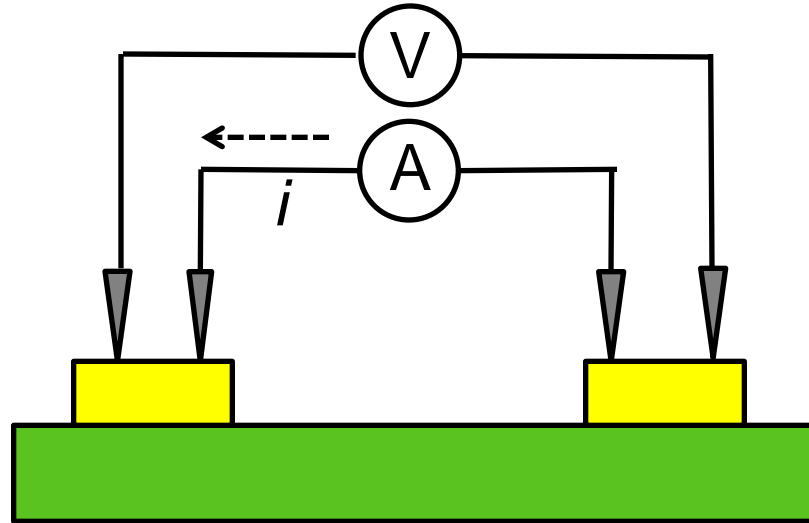
R_n =needle
resistance

R_c =contact
resistance



R_s =semiconductor
resistance

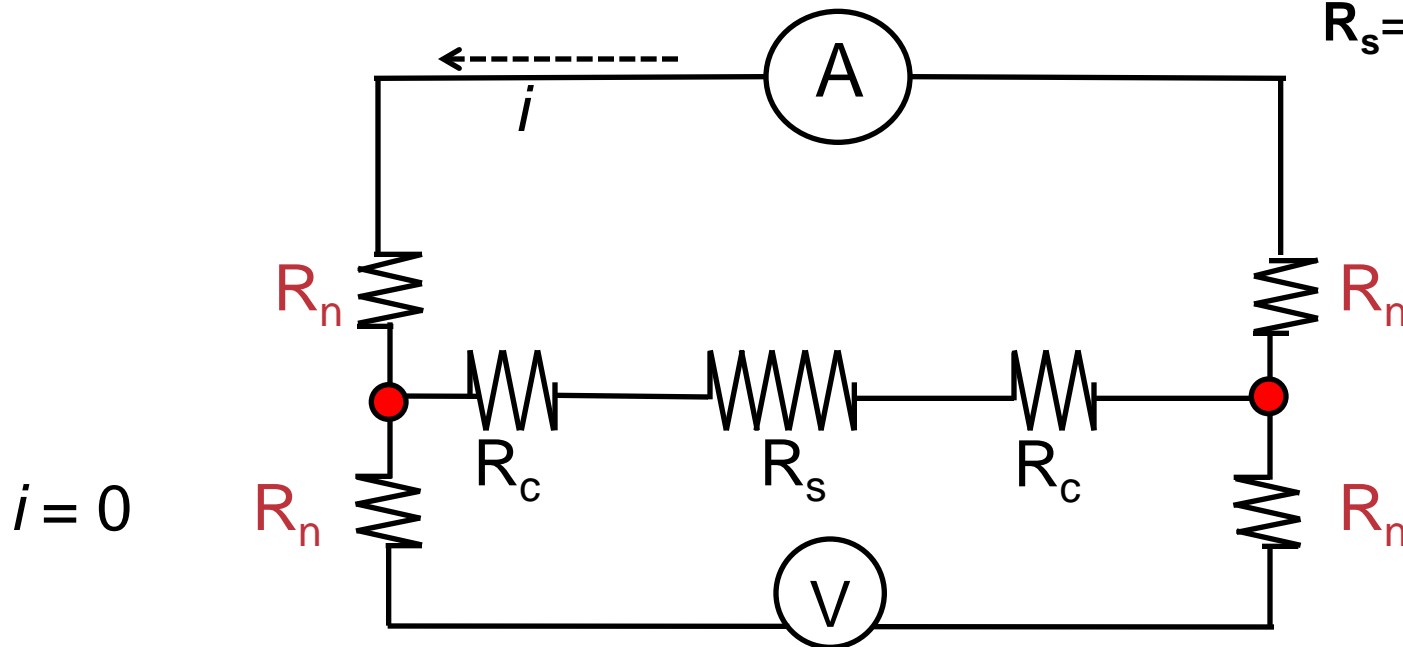
Four Point Probe Method



R_n =needle
resistance

R_c =contact
resistance

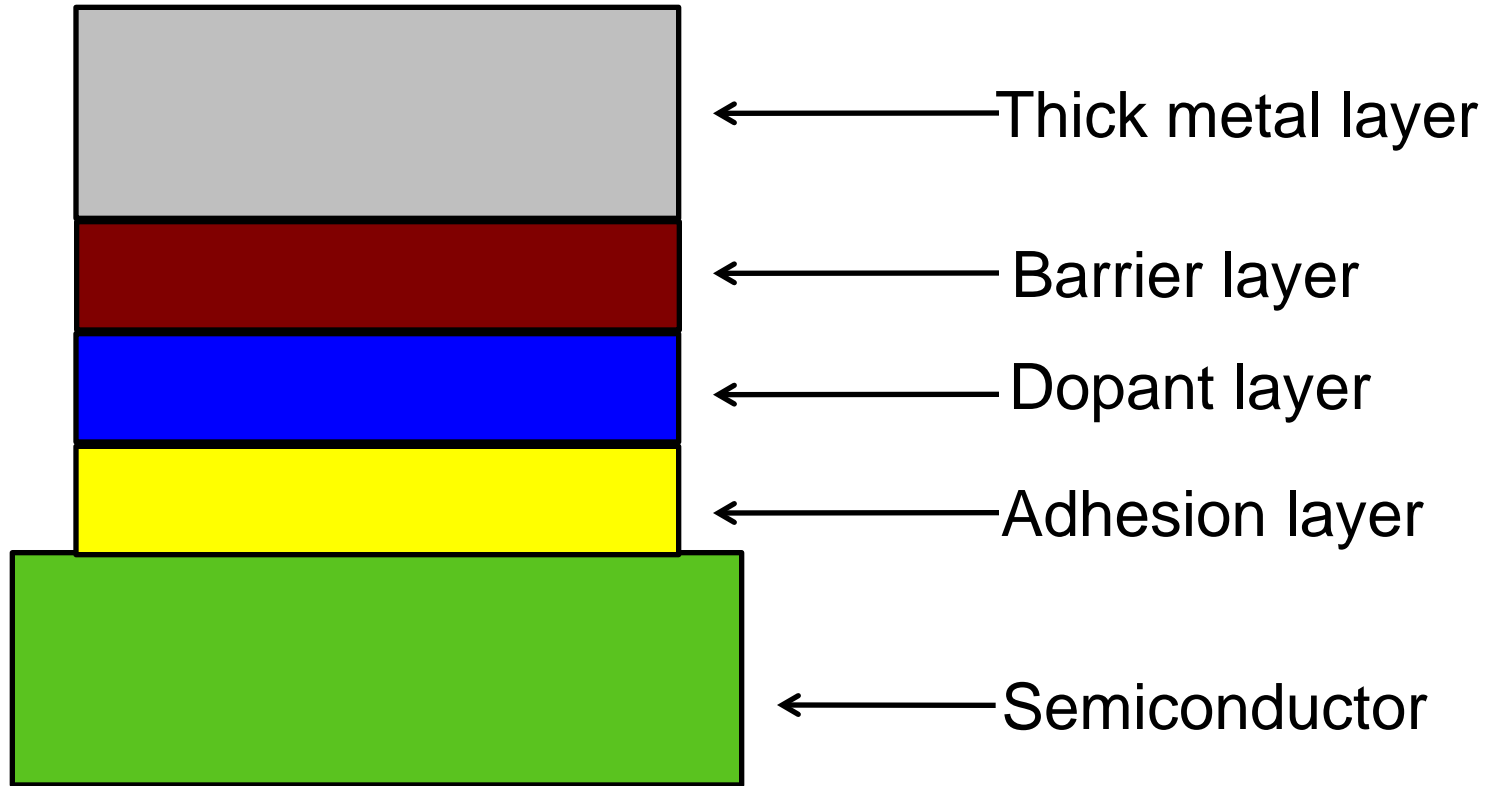
R_s =semiconductor
resistance



Outline

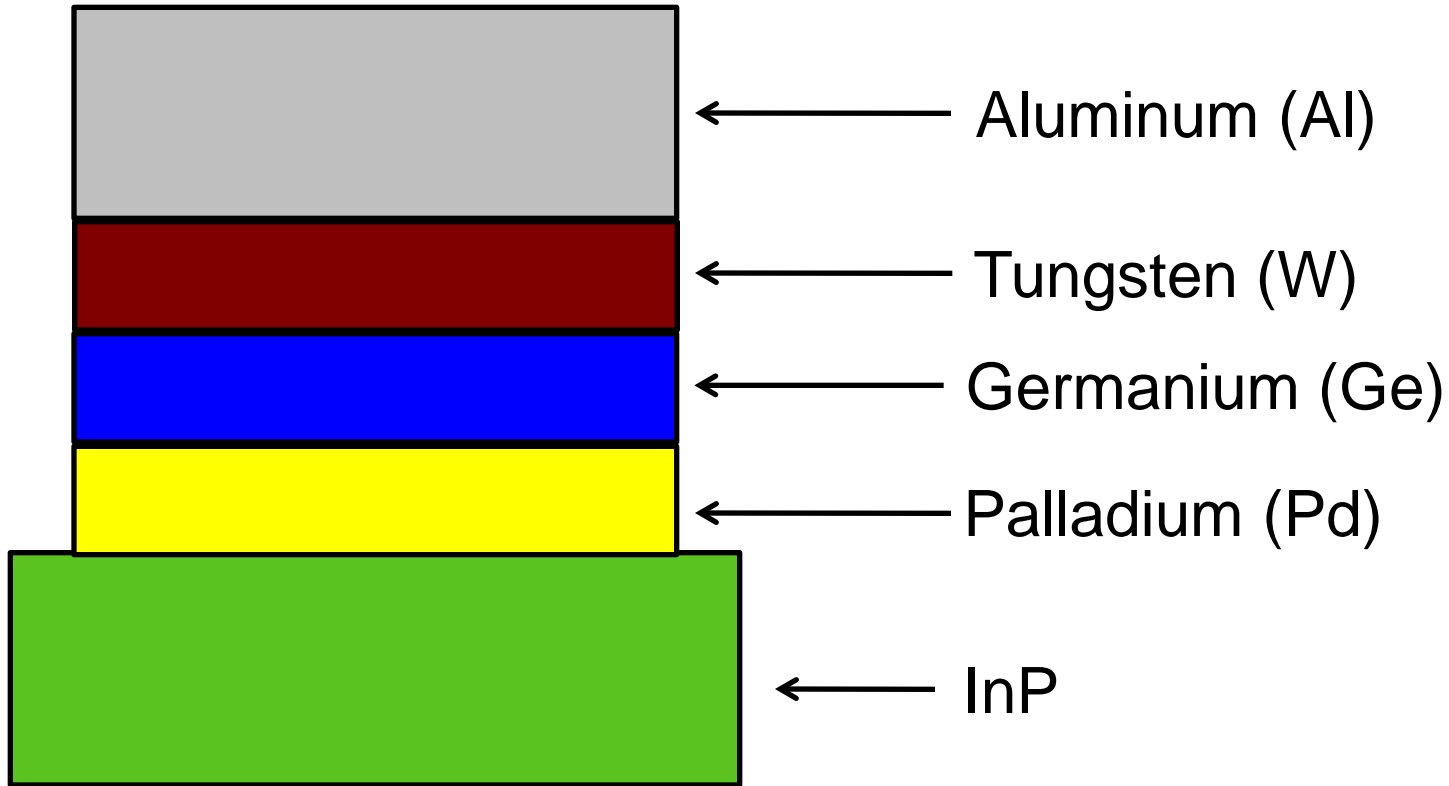
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Anatomy of a metal contact



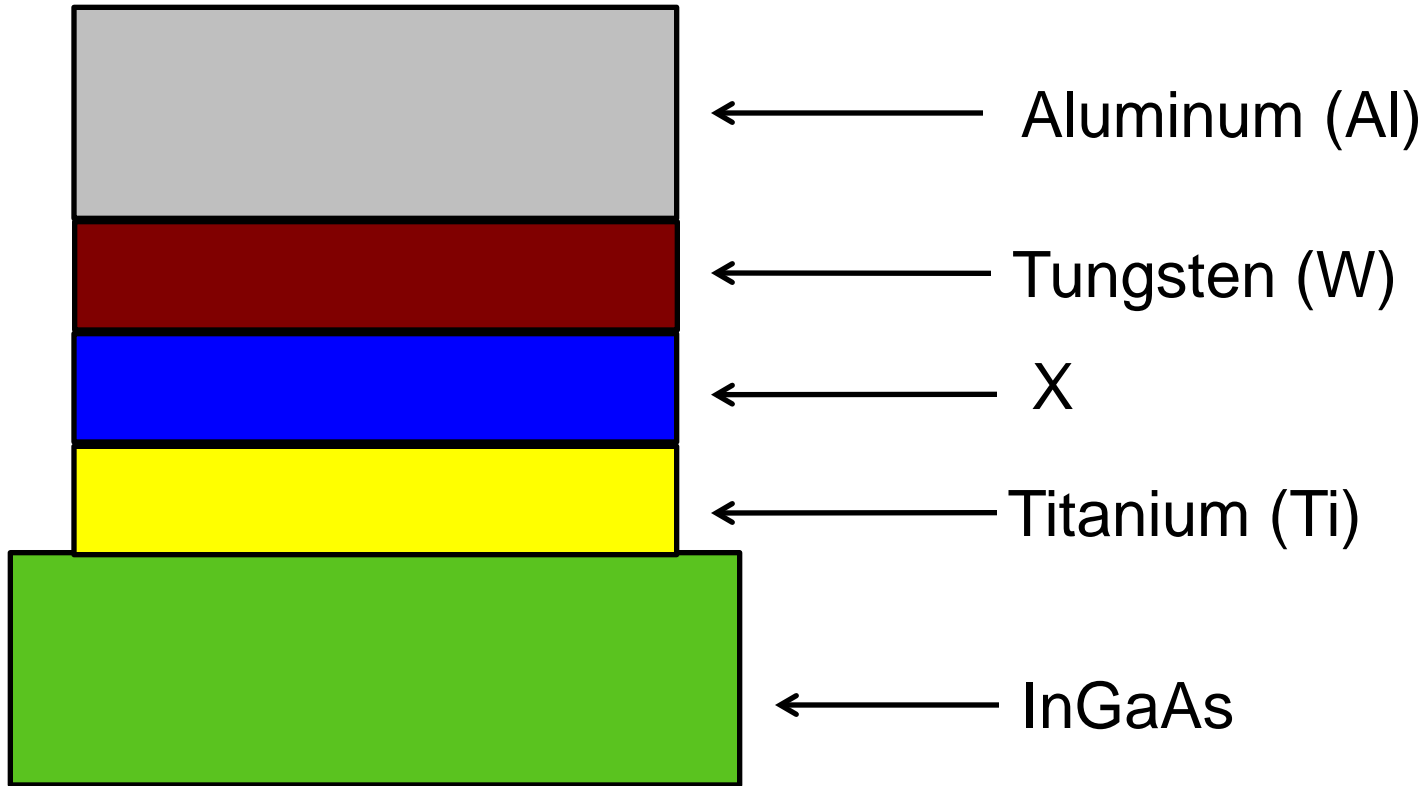
Anatomy of a metal contact

On Indium Phosphide (InP):



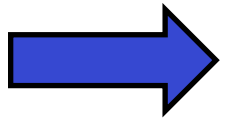
Anatomy of a metal contact

On Indium Gallium Arsenide (InGaAs):



Outline

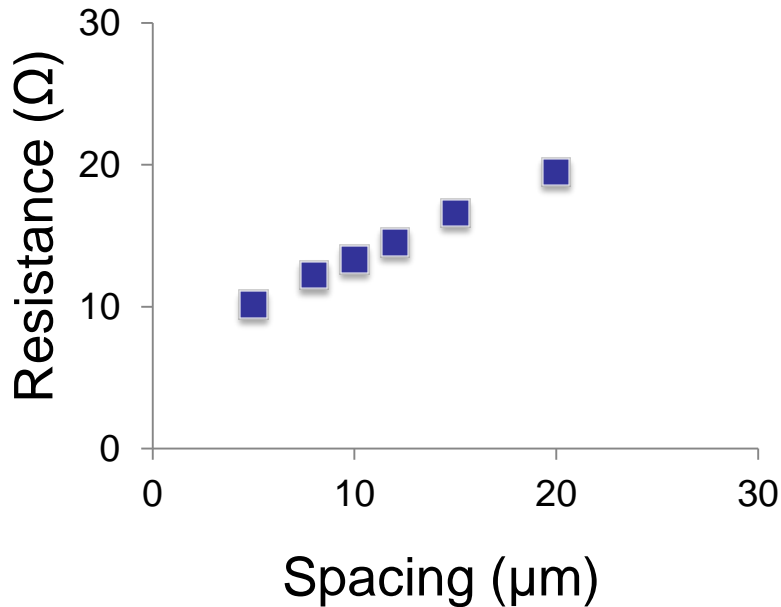
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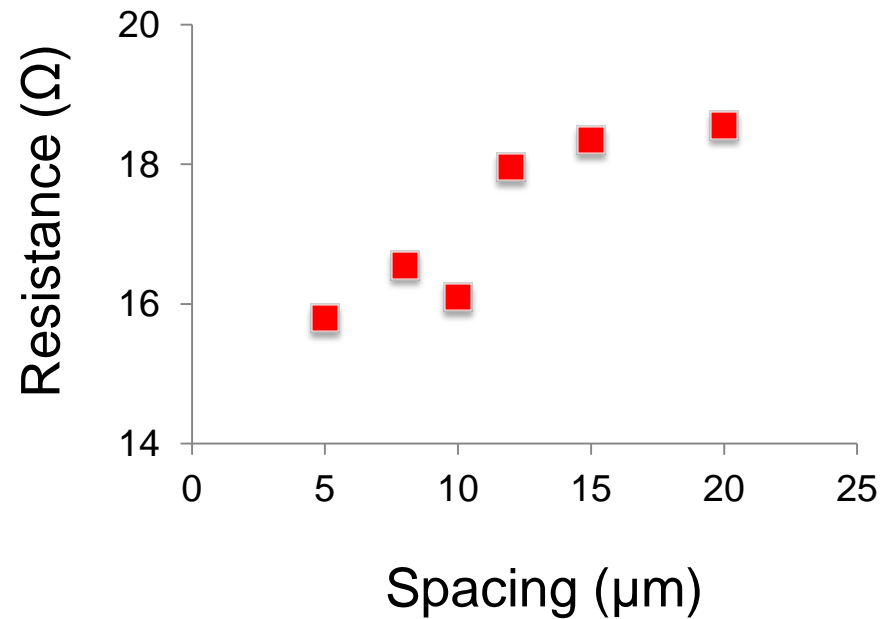
Measurement results

Non-annealed samples

Ti/W/Al on InP



Pd/Ge/Pd/W/Al on InP

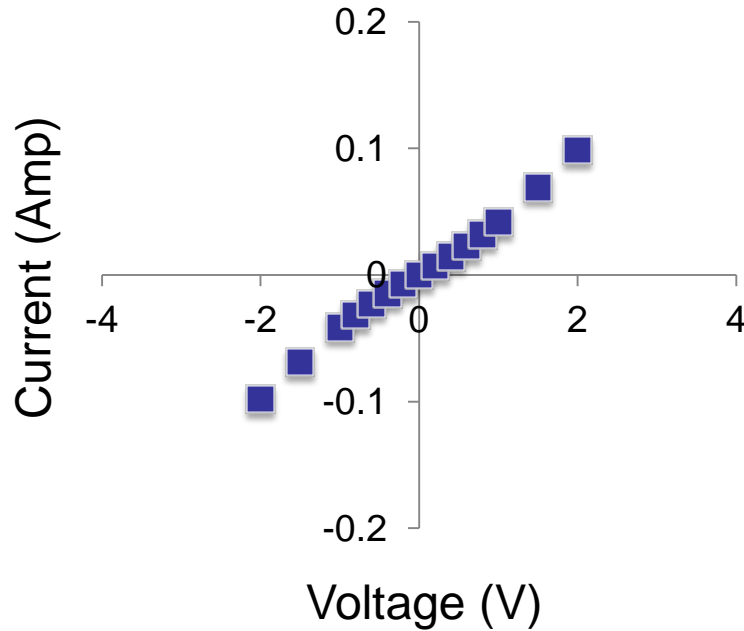


Some samples not even linear
→ non-linear = not *Ohmic*

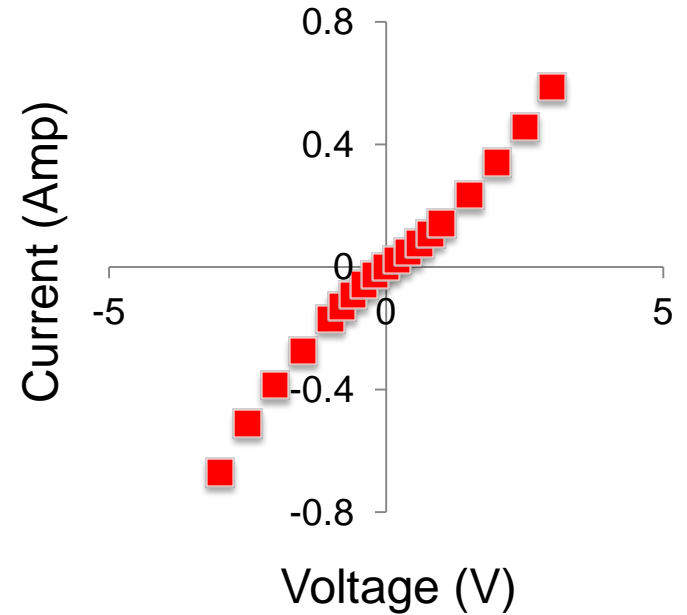
[Ohmic: $V = iR$]

Non-annealed samples

Ti/W/Al



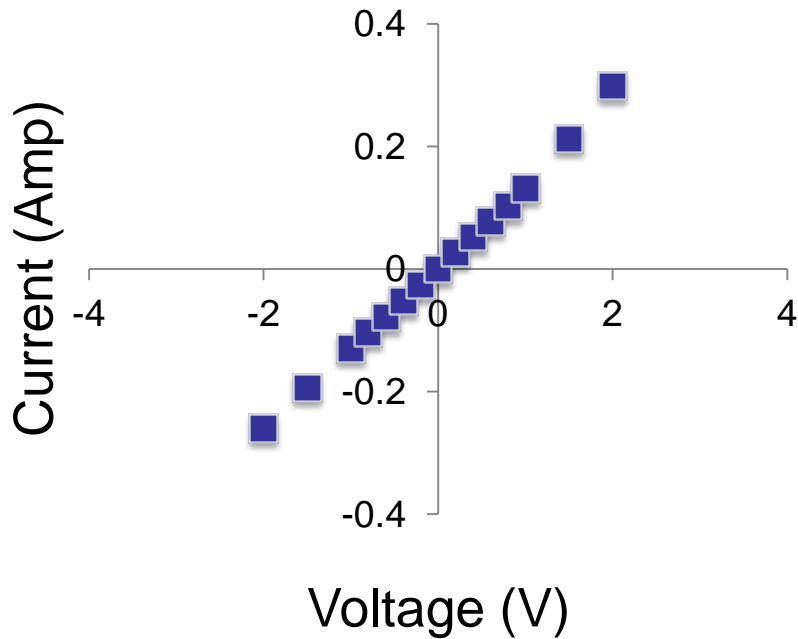
Pd/Ge/Pd/W/Al



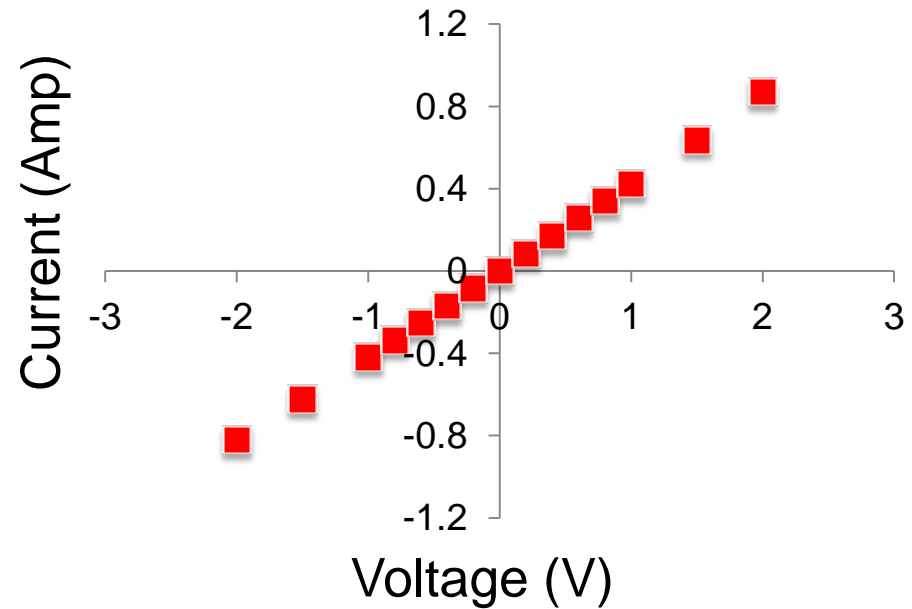
Ohmic: Linear relationship between voltage and current
(Contacts must be Ohmic)

Annealed at 350°C, 30 sec

Ti/W/Al

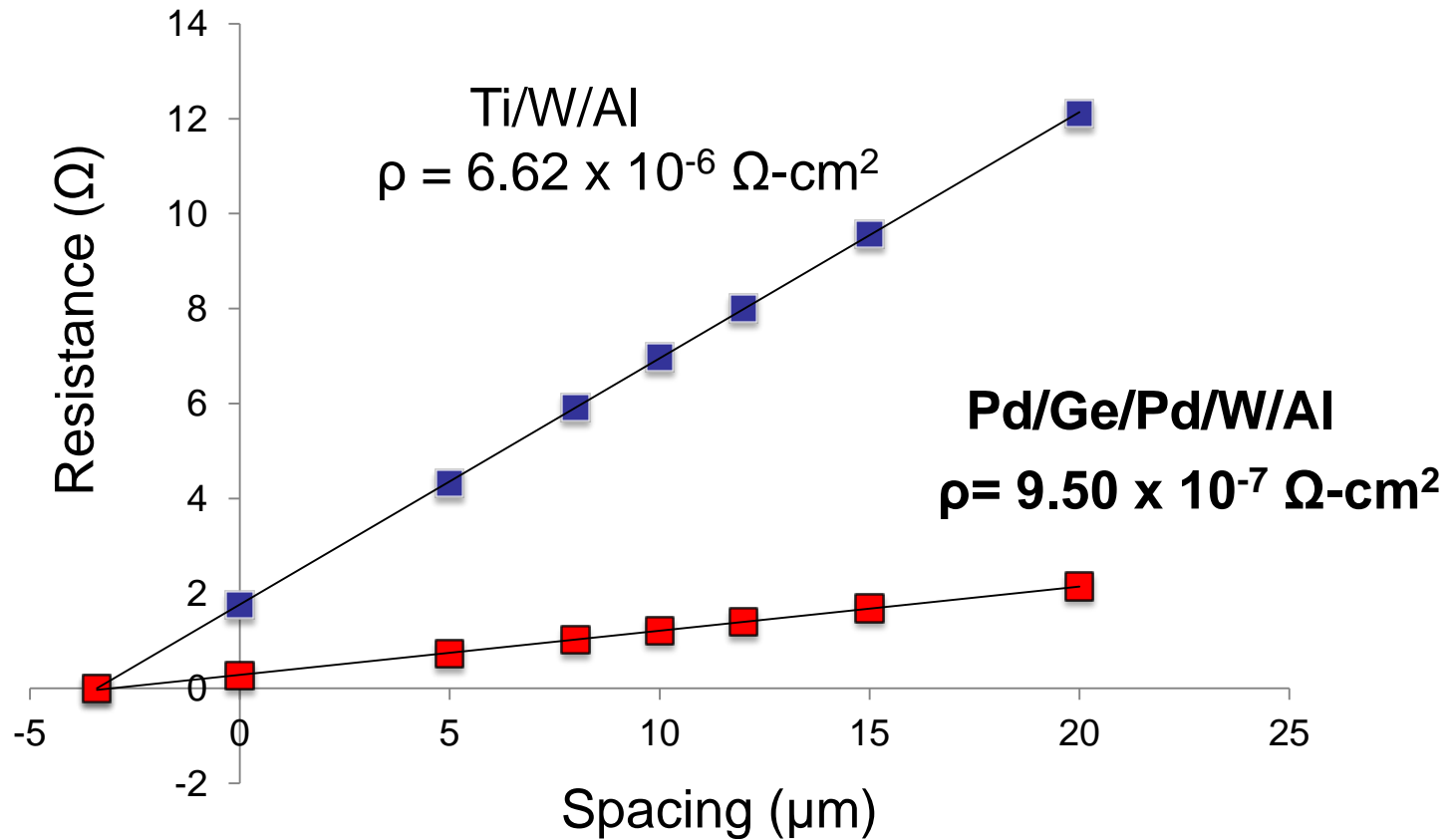


Pd/Ge/Pd/W/Al



After annealing, both samples are Ohmic

Which contact has lowest resistance?



Looking ahead...

- Two possible semiconductors: InP and InGaAs
- Find contact that will work equally well on both
 - Simplifies manufacturing

InP → lots of Germanium

InGaAs → less Germanium

